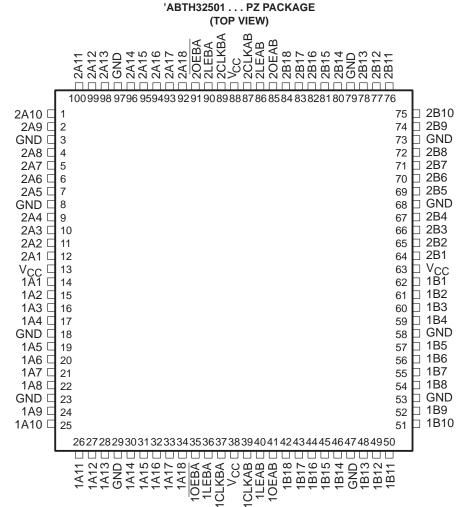
SN54ABTH32501, SN74ABTH32501 36-BIT UNIVERSAL BUS TRANSCEIVERS WITH 3-STATE OUTPUTS SCBS229F – JUNE 1992 – REVISED MAY 1997

- Members of the Texas Instruments *Widebus+*[™] Family
- State-of-the-Art *EPIC-*II*B*[™] BiCMOS Design Significantly Reduces Power Dissipation
- UBT[™] (Universal Bus Transceiver) Combines D-Type Latches and D-Type Flip-Flops for Operation in Transparent, Latched, or Clocked Mode
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Released as DSCC SMD 5962-9557601NXD

- Typical V_{OLP} (Output Ground Bounce) < 0.8 V at V_{CC} = 5 V, T_A = 25°C
- High-Impedance State During Power Up and Power Down
- Distributed V_{CC} and GND Pin Configuration Minimizes High-Speed Switching Noise
- High-Drive Outputs (–32-mA I_{OH}, 64-mA I_{OL})
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Package Options Include 100-Pin Plastic Thin Quad Flat (PZ) Package With 14 × 14-mm Body Using 0.5-mm Lead Pitch and Space-Saving 100-Pin Ceramic Quad Flat (HS) Package[†]



[†]The HS package is not production released.



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RUMENTS

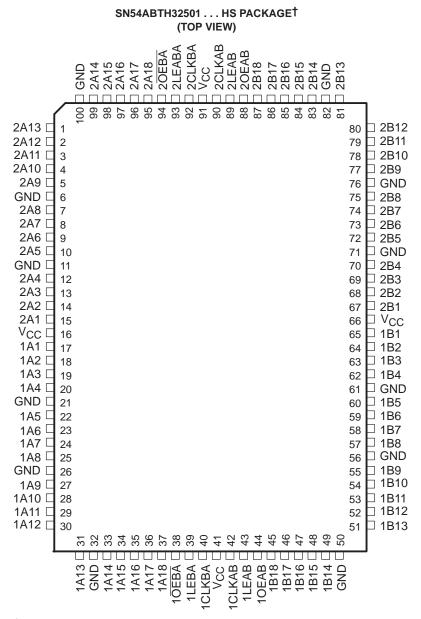
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[†] For HS package availability, please contact the factory or your local TI Field Sales Office.



description

These 36-bit UBTs combine D-type latches and D-type flip-flops to allow data flow in transparent, latched, and clocked modes.

Data flow in each direction is controlled by output-enable (OEAB and OEBA), latch-enable (LEAB and LEBA), and clock (CLKAB and CLKBA) inputs. For A-to-B data flow, the device operates in the transparent mode when LEAB is high. When LEAB is low, the A data is latched if CLKAB is held at a high or low logic level. If LEAB is low, the A data is stored in the latch/flip-flop on the low-to-high transition of CLKAB. Data flow for B to A is similar to that of A to B, but uses OEBA, LEBA, and CLKBA.

Output-enable OEAB is active high. When OEAB is high, the outputs are active. When OEAB is low, the outputs are in the high-impedance state. The output enables are complementary (OEAB is active high, and OEBA is active low).

When V_{CC} is between 0 and 2.1 V, the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above 2.1 V, \overline{OE} should be tied to V_{CC} through a pullup resistor and OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

The SN54ABTH32501 is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ABTH32501 is characterized for operation from –40°C to 85°C.

FUNCTION TABLET								
	OUTPUT							
OEAB	LEAB	В						
L	Х	Х	Х	Z				
н	Н	Х	L	L				
н	Н	Х	Н	н				
н	L	\uparrow	L	L				
н	L	\uparrow	Н	н				
н	L	Н	Х	в ₀ ‡ в ₀ §				
н	L	L	Х	в ₀ §				

[†] A-to-<u>B data</u> flow is shown: B-to-A flow is similar, but uses OEBA, LEBA, and CLKBA.

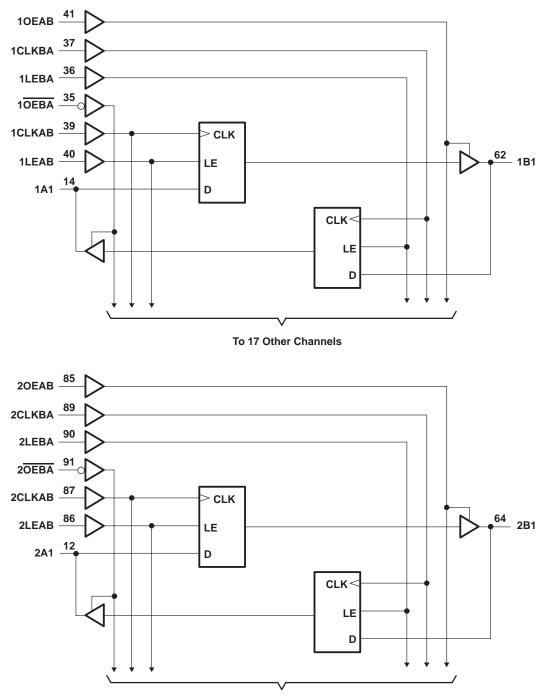
[‡]Output level before the indicated steady-state input conditions were established

Soutput level before the indicated steady-state input conditions were established, provided that CLKAB was low before LEAB went low



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logic diagram (positive logic)



To 17 Other Channels

Pin numbers shown are for the PZ package.



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

2. The package thermal impedance is calculated in accordance with EIA/JEDEC Std JESD51.

recommended operating conditions (see Note 3)

			SN54ABTI	H32501	SN74ABT	H32501	UNIT
			MIN	MAX	MIN	MAX	UNIT
VCC	Supply voltage	4.5	5.5	4.5	5.5	V	
VIH	High-level input voltage	2		2		V	
VIL	Low-level input voltage			0.8		0.8	V
VI	Input voltage			VCC	0	VCC	V
IOH	High-level output current			-24		-32	mA
IOL	Low-level output current			48		64	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	Outputs enabled		10		10	ns/V
Δt/ΔV _{CC}	Power-up ramp rate		200		200		μs/V
Тд	Operating free-air temperature		-55	125	-40	85	°C

NOTE 3: Unused control pins must be held high or low to prevent them from floating.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DA	RAMETER	TEST CONDITIONS		SN54	4ABTH3	2501	SN74	ABTH32	2501		
PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	MIN	TYP [†]	MAX	UNIT	
VIK		$V_{CC} = 4.5 V$, $I_{I} = -18 mA$				-1.2			-1.2	V	
		V _{CC} = 4.5 V,	I _{OH} = -3 mA	2.5			2.5				
Val		V _{CC} = 5 V,	$I_{OH} = -3 \text{ mA}$	3			3				
Vон		V _{CC} = 4.5 V	I _{OH} = -24 mA	2						v	
		VCC = 4.5 V	I _{OH} = -32 mA				2				
VOL		V _{CC} = 4.5 V	I _{OL} = 48 mA			0.55			0.55	V	
VOL		VCC = 4.5 V	I _{OL} = 64 mA						0.55	v	
V _{hys}					100			100		mV	
	Control inputs	$V_{CC} = 0$ to 5.5 V,	$V_I = V_{CC} \text{ or } GND$						±1		
	A or B ports	$V_{CC} = 2.1 V \text{ to } 5.5 V,$	$V_I = V_{CC} \text{ or } GND$						±20	μΑ	
łı	Control inputs	V _{CC} = 5.5 V,				±5					
	A or B ports	vCC = 5.5 v,	$V_I = V_{CC} \text{ or } GND$			±50					
1.a		V _{CC} = 4.5 V	V _I = 0.8 V	100			100			μA	
II(hold) A or B ports		VCC = 4.5 V	V _I = 2 V	-100			-100			μΑ	
IOZPU‡	ŧ	$V_{CC} = 0$ to 2.1 V, $V_O = 0.5$ OE or $\overline{OE} = X$	V to 2.7 V,			±50			±50	μA	
I _{OZPD} ‡	ŧ	$V_{CC} = 2.1 \text{ V to 0}, V_{O} = 0.5$ OE or OE = X	V to 2.7 V,			±50			±50	μA	
loff		$V_{CC} = 0,$	$V_{I} \text{ or } V_{O} \leq 4.5 \text{ V}$						±100	μA	
ICEX		V _{CC} = 5.5 V, V _O = 5.5 V	Outputs high			50			50	μΑ	
IO§		V _{CC} = 5.5 V,	V _O = 2.5 V	-50	-100	-180	-50	-100	-180	mA	
			Outputs high			6			6		
ICC		$V_{CC} = 5.5 \text{ V}, I_O = 0,$ $V_I = V_{CC} \text{ or GND}$	Outputs low			90			90	mA	
		Outputs disab				6			6	1	
∆lcc¶		V_{CC} = 5.5 V, One input at 3 Other inputs at V_{CC} or GNI				1			1	mA	
Ci	Control inputs	V _I = 2.5 V or 0.5 V			3.5			3.5		pF	
Cio	A or B ports	V _O = 2.5 V or 0.5 V			11.5			11.5		pF	

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[‡] This parameter is specified by characterization.

§ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.

 \P This is the increase in supply current for each input that is at the specified TTL voltage level rather than V_{CC} or GND.

timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

			SN54ABT	H32501	SN74ABTI	H32501	UNIT	
			MIN	MAX	MIN	MAX	UNIT	
fclock	Clock frequency		0	150	0	150	MHz	
	Pulse duration	LE high	3.5		3.3			
tw	CLK high or low		3.5		3.3		ns	
	Satur time	A or B before CLK↑	4.3		3.5			
t _{su}	Setup time	A or B before LE \downarrow	2.5		1.6		ns	
th	Hold time	A or B after CLK [↑]			0		-	
	Hold time A or B after LE↓				1.6		ns	



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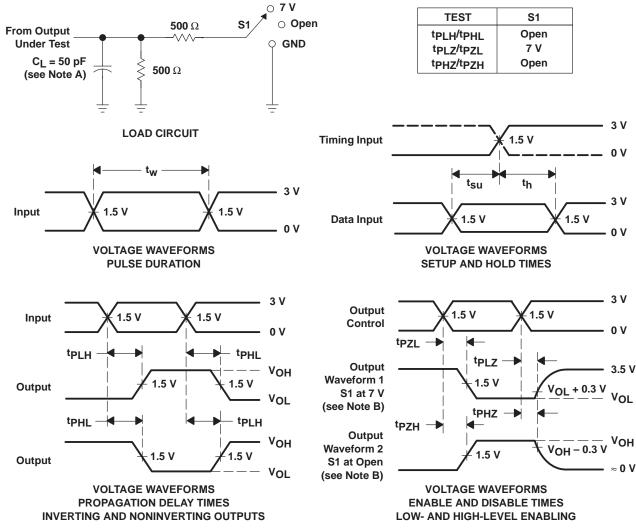
switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $C_L = 50 \text{ pF}$ (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	SN54	SN54ABTH32501			SN74ABTH32501		
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP [†]	MAX	MIN	TYP†	MAX	UNIT
f _{max}			150			150			MHz
^t PLH	A or B	B or A	0.5	2.9	5.2	1.3	2.9	4.8	ns
^t PHL	AUIB	BUIA	0.5	2.7	5.8	1.4	2.7	5.4	115
^t PLH	LEAB or LEBA	A or B	0.7	3.4	5.7	1.6	3.4	5.3	-
^t PHL	LEAD OF LEDA	AUID	0.7	3.6	5.9	1.9	3.6	5.5	ns
^t PLH	CLKAB or CLKBA	A or B	0.5	3.2	5.7	1.5	3.2	5.3	
^t PHL	CLKAD UI CLKDA	AUB	0.7	3.3	5.8	1.7	3.3	5.4	ns
^t PZH		A or B	0.5	3.2	6.2	1.2	3.2	5.6	
^t PZL	OEAB or OEBA	AUB	0.5	3.6	6.6	1.5	3.6	6	ns
^t PHZ	OEAB or OEBA	A or B	0.7	3.6	7	1.8	3.6	5.9	
^t PLZ		AUID	0.7	3.5	6.1	1.7	3.5	5.6	ns

[†] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$.



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PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.

C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_Q = 50 Ω , t_f \leq 2.5 ns. t_f \leq 2.5 ns.

D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins Pa	ackage Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
5962-9557601NXD	OBSOLETE	LQFP	PZ	100		TBD	Call TI	Call TI
SN74ABTH32501PZ	ACTIVE	LQFP	ΡZ	100	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR
SN74ABTH32501PZG4	ACTIVE	LQFP	ΡZ	100	90	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-3-260C-168 HR

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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Enhanced Product: SN74ABTH32501-EP

NOTE: Qualified Version Definitions:

• Enhanced Product - Supports Defense, Aerospace and Medical Applications

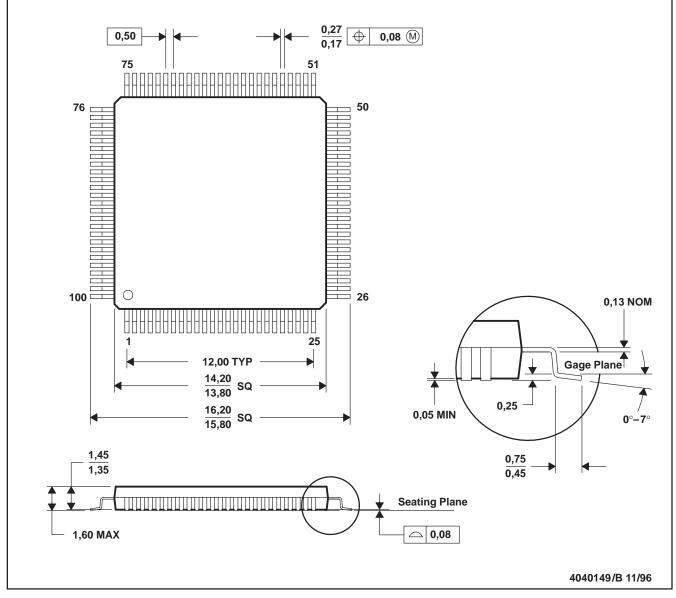


MECHANICAL DATA

MTQF013A - OCTOBER 1994 - REVISED DECEMBER 1996

PZ (S-PQFP-G100)

PLASTIC QUAD FLATPACK



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Falls within JEDEC MS-026



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